

650V N-ch Planar MOSFET

General Features

- RoHS Compliant
- $\succ R_{DS(ON),typ} = 1.9 \ \Omega @V_{GS} = 10V$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

- Adaptor
- Charger
- SMPS Standby Power

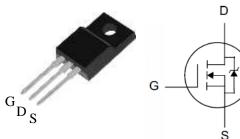
Ordering Information

Part Number	Package	Brand
PSA04N65B	TO-220F	ï

Absolute Maximum Ratings



BV _{DSS}	R _{DS(ON),typ} .	I _D
650V	1.9Ω	4.0A



TO-220F Package No to Scale

 $T_C{=}25\,^\circ\!\mathrm{C}$ unless otherwise specified

Symbol	Parameter	PSA04N65B	Unit	
V _{DSS}	Drain-to-Source Voltage	650		
V _{GSS}	Gate-to-Source Voltage	±30	V	
Ι _D	Continuous Drain Current	4.0	٨	
I _{DM} Pulsed Drain Current at V _{GS} =10V		16	A	
E _{AS}	Single Pulse Avalanche Energy	250	mJ	
Р	Power Dissipation	30	W	
P _D	Derating Factor above 25℃	0.24	W/°C	
T_L	TL Soldering Temperature 300 Distance of 1.6mm from case for 10 seconds 300		°C	
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150	C	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PSA04N65B	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case	4.17	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	100	°C / W

Electrical Characteristics

OFF Characteristics

OFF Characteristics $T_J = 25^{\circ}C$ unless otherwise spectrum						inless otherwise specified
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	650			V	V_{GS} =0V, I_{D} =250uA
I _{DSS}	Drain-to-Source Leakage Current			1	uA	V _{DS} =650V, V _{GS} =0V
				100		V _{DS} =520V, V _{GS} =0V, T _J =125℃
	Gate-to-Source Leakage Current +10 10	ΠA	V_{GS} =+20V, V_{DS} =0V			
I _{GSS}				-10	üΑ	V _{GS} =-20V, V _{DS} =0V

ON Characteristics

IN Characteristics				TJ	ı =25° ℃ u	Inless otherwise specified
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance		1.9	2.5	Ω	V _{GS} =10V, I _D =2.0A
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$, $I_D=250uA$
gfs	Forward Transconductance		5.0		S	V _{DS} =15V,ID=2.0A

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		450			V 0V
C _{rss}	Reverse Transfer Capacitance		6.0		pF	V _{GS} =0V, V _{DS} =25V, f=1.0MH _Z
C _{oss}	Output Capacitance		50			
Qg	Total Gate Charge		8.5			
Q _{gs}	Gate-to-Source Charge		2.8		nC	V_{DD} =325V, I _D =4A, V_{GS} =0 to 10V
Q _{gd}	Gate-to-Drain (Miller) Charge		2.5			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		9.0			
trise	Rise Time		7.0			V_{DD} =325V, I_{D} =4A, V_{GS} =10V Rg=4.7 Ω
td(OFF)	Turn-Off Delay Time		22		nS	
tfall	Fall Time		9.0			



Source-Drain Body Diode Characteristics

 $T_J\!=\!25\,^\circ\!\mathrm{C}$ unless otherwise specified

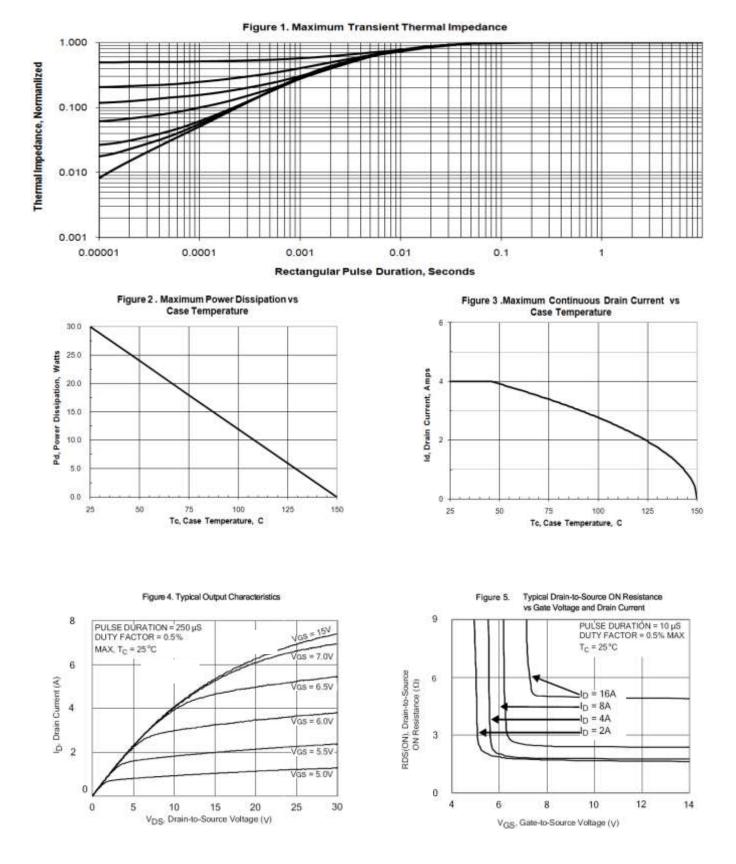
Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[2]			4.0	~	Integral pn-diode
I _{SM}	Pulsed Source Current ^[2]			16	A	in MOSFET
V_{SD}	Diode Forward Voltage			1.5	V	I _S =4A, V _{GS} =0V
trr	Reverse Recovery Time		235		ns	Vgs=0V
Qrr	Reverse Recovery Charge		750		nC	I⊧= I _S , di/dt=100A/µs

Note:

- $\label{eq:constraint} \begin{array}{l} \mbox{[1]} \ T_{\mbox{J}}\mbox{=}+25\,^{\circ}\mbox{C} & \mbox{to }+150\,^{\circ}\mbox{C} \\ \mbox{[2]} \ \mbox{Pulse width}\mbox{=}380\mbox{μs; duty cycle}\mbox{=}2\%. \end{array}$

Typical Characteristics

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Typical Characteristics(Cont.)

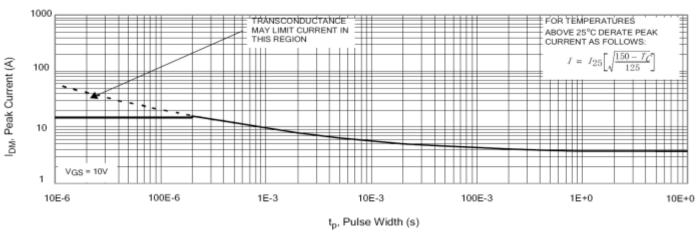
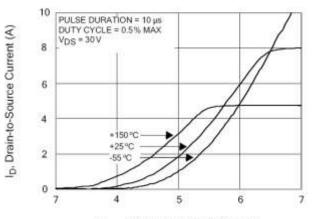
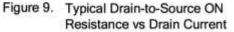


Figure 6. Maximum Peak Current Capability



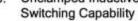


V_{GS}, Gate-to-Source Voltage (V)



Rps(on), Drain-to-Source





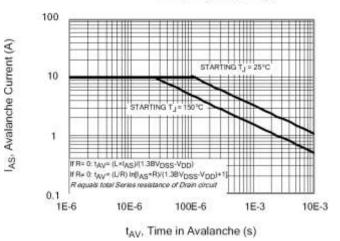
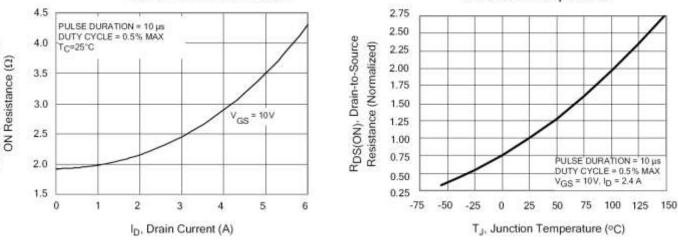
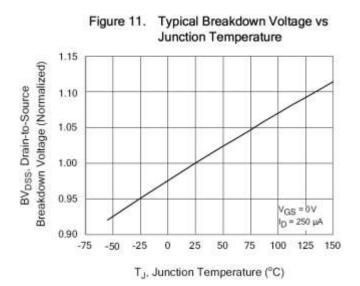
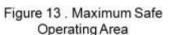


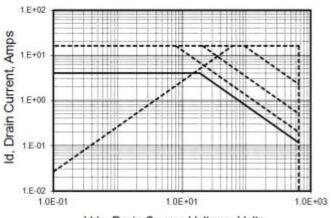
Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature



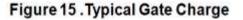
Typical Characteristics(Cont.)

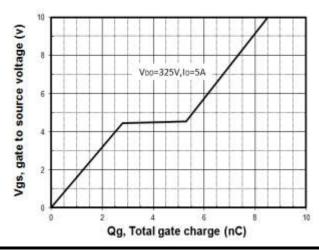






Vds, Drain Source Voltage, Volts





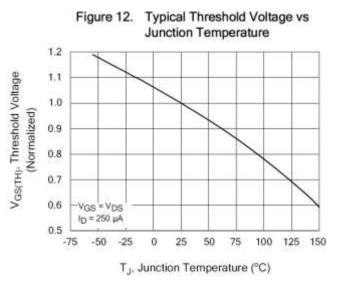
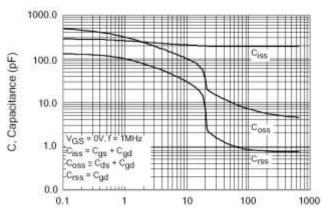
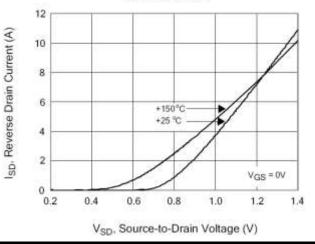


Figure 14. Typical Capacitance vs Drain-to-Source Voltage

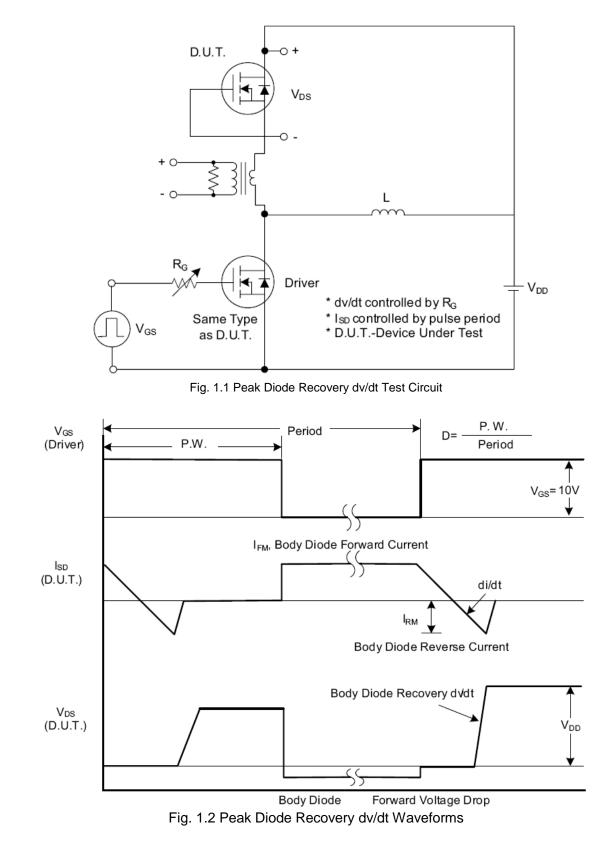


V_{DS}, Drain Voltage (V)

Figure 16. Typical Body Diode Transfer Characteristics



Test Circuits and Waveforms



Test Circuits and Waveforms (Cont.)

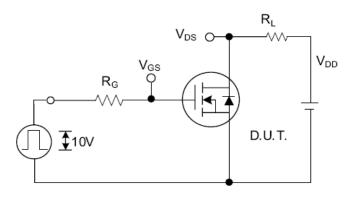


Fig. 2.1 Switching Test Circuit

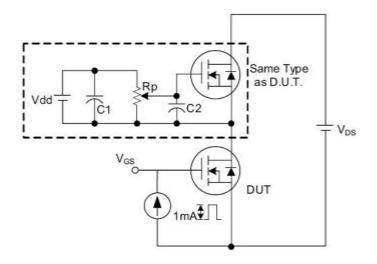


Fig. 3.1 Gate Charge Test Circuit

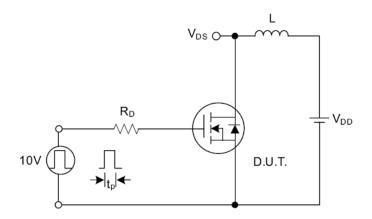


Fig. 4.1 Unclamped Inductive Switching Test Circuit

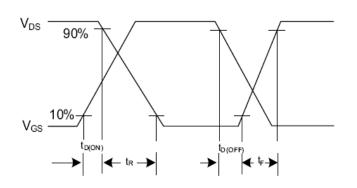
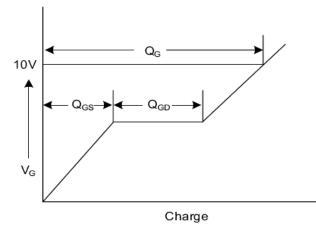
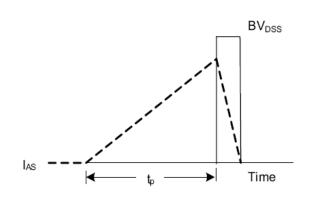
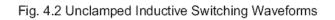


Fig. 2.2 Switching Waveforms









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